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#### [Understanding Embedded - FPGAs \(Field Programmable Gate Array\)](#)

Embedded - FPGAs, or Field Programmable Gate Arrays, are advanced integrated circuits that offer unparalleled flexibility and performance for digital systems. Unlike traditional fixed-function logic devices, FPGAs can be programmed and reprogrammed to execute a wide array of logical operations, enabling customized functionality tailored to specific applications. This reprogrammability allows developers to iterate designs quickly and implement complex functions without the need for custom hardware.

#### **Applications of Embedded - FPGAs**

The versatility of Embedded - FPGAs makes them indispensable in numerous fields. In telecommunications.

#### **Details**

Product Status	Active
Number of LABs/CLBs	-
Number of Logic Elements/Cells	-
Total RAM Bits	-
Number of I/O	140
Number of Gates	24000
Voltage - Supply	3V ~ 3.6V, 4.5V ~ 5.5V
Mounting Type	Surface Mount
Operating Temperature	-55°C ~ 125°C (TC)
Package / Case	176-LQFP
Supplier Device Package	176-TQFP (24x24)
Purchase URL	<a href="https://www.e-xfl.com/product-detail/microchip-technology/a42mx16-tqg176m">https://www.e-xfl.com/product-detail/microchip-technology/a42mx16-tqg176m</a>

# Tables

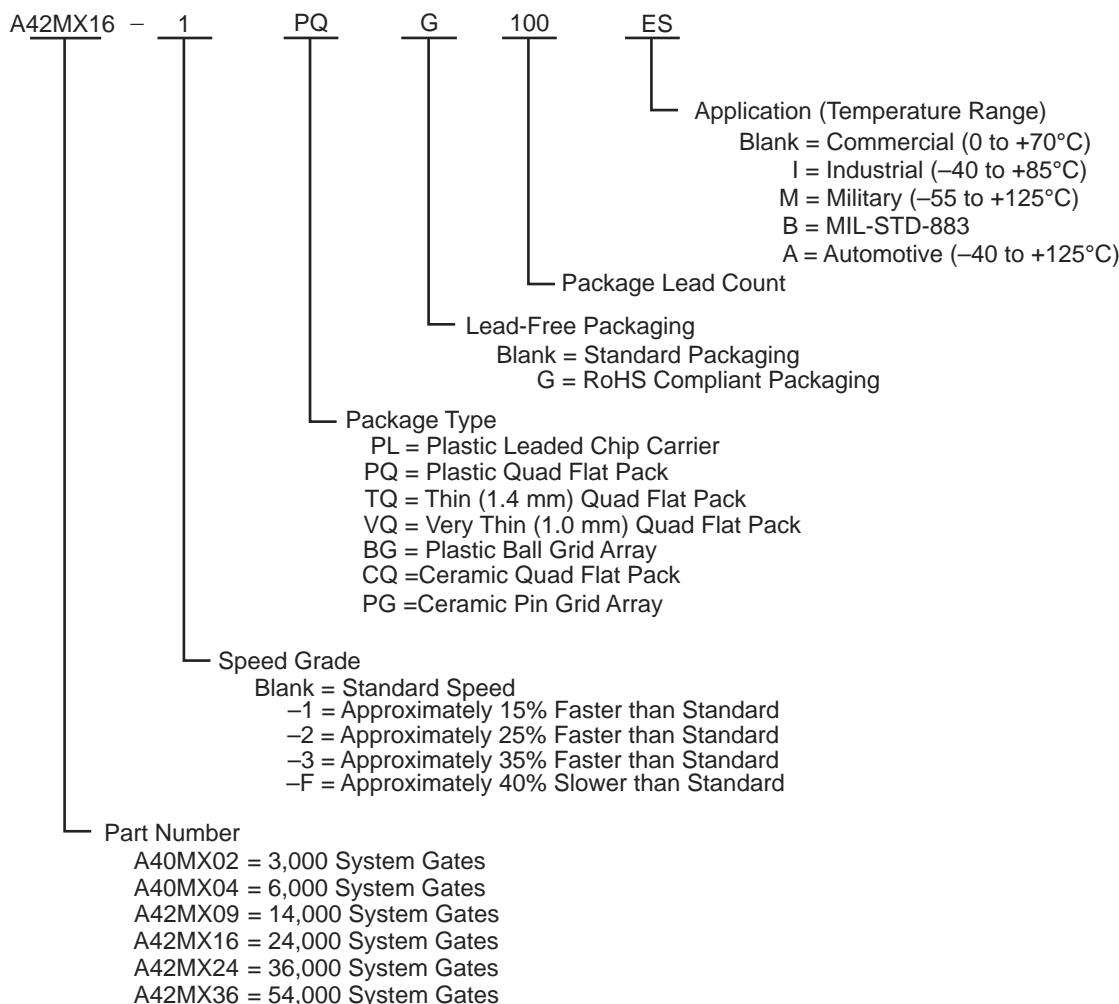
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## 2.3 Ordering Information

The following figure shows ordering information. All the following tables show plastic and ceramic device resources, temperature and speed grade offerings.

**Figure 1 • Ordering Information**



## 3 40MX and 42MX FPGAs

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### 3.1 General Description

Microsemi's 40MX and 42MX families offer a cost-effective design solution at 5V. The MX devices are single-chip solutions and provide high performance while shortening the system design and development cycle. MX devices can integrate and consolidate logic implemented in multiple PALs, CPLDs, and FPGAs. Example applications include high-speed controllers and address decoding, peripheral bus interfaces, DSP, and co-processor functions.

The MX device architecture is based on Microsemi's patented antifuse technology implemented in a 0.45 $\mu$ m triple-metal CMOS process. With capacities ranging from 3,000 to 54,000 system gates, the MX devices provide performance up to 250 MHz, are live on power-up and have one-fifth the standby power consumption of comparable FPGAs. MX FPGAs provide up to 202 user I/Os and are available in a wide variety of packages and speed grades.

A42MX24 and A42MX36 devices also feature multiPlex I/Os, which support mixed-voltage systems, enable programmable PCI, deliver high-performance operation at both 5.0V and 3.3V, and provide a low-power mode. The devices are fully compliant with the PCI local bus specification (version 2.1). They deliver 200 MHz on-chip operation and 6.1 ns clock-to-output performance.

The 42MX24 and 42MX36 devices include system-level features such as IEEE Standard 1149.1 (JTAG) Boundary Scan Testing and fast wide-decode modules. In addition, the A42MX36 device offers dual-port SRAM for implementing fast FIFOs, LIFOs, and temporary data storage. The storage elements can efficiently address applications requiring wide data path manipulation and can perform transformation functions such as those required for telecommunications, networking, and DSP.

All MX devices are fully tested over automotive and military temperature ranges. In addition, the largest member of the family, the A42MX36, is available in both CQ208 and CQ256 ceramic packages screened to MIL-STD-883 levels. For easy prototyping and conversion from plastic to ceramic, the CQ208 and PQ208 devices are pin-compatible.

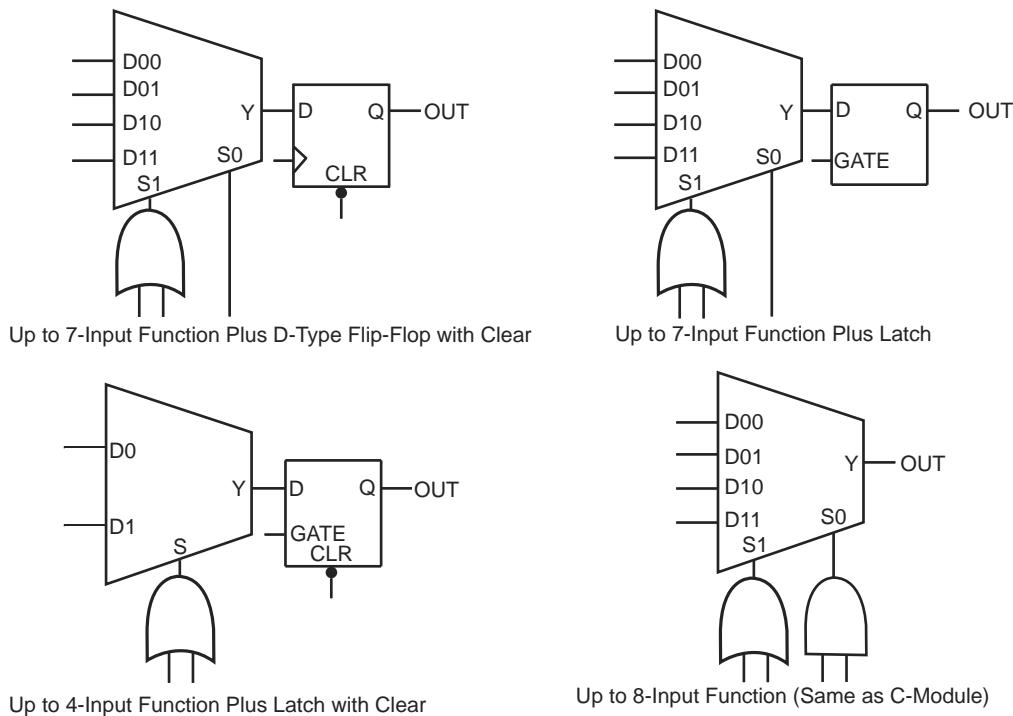
### 3.2 MX Architectural Overview

The MX devices are composed of fine-grained building blocks that enable fast, efficient logic designs. All devices within these families are composed of logic modules, I/O modules, routing resources and clock networks, which are the building blocks for fast logic designs. In addition, the A42MX36 device contains embedded dual-port SRAM modules, which are optimized for high-speed data path functions such as FIFOs, LIFOs and scratch pad memory. A42MX24 and A42MX36 also contain wide-decode modules.

#### 3.2.1 Logic Modules

The 40MX logic module is an eight-input, one-output logic circuit designed to implement a wide range of logic functions with efficient use of interconnect routing resources.(see the following figure).

The logic module can implement the four basic logic functions (NAND, AND, OR and NOR) in gates of two, three, or four inputs. The logic module can also implement a variety of D-latches, exclusivity functions, AND-ORs and OR-ANDs. No dedicated hard-wired latches or flip-flops are required in the array; latches and flip-flops can be constructed from logic modules whenever required in the application.

**Figure 4 • 42MX S-Module Implementation**

A42MX24 and A42MX36 devices contain D-modules, which are arranged around the periphery of the device. D-modules contain wide-decode circuitry, providing a fast, wide-input AND function similar to that found in CPLD architectures (Figure 5, page 9). The D-module allows A42MX24 and A42MX36 devices to perform wide-decode functions at speeds comparable to CPLDs and PALs. The output of the D-module has a programmable inverter for active HIGH or LOW assertion. The D-module output is hardwired to an output pin, and can also be fed back into the array to be incorporated into other logic.

### 3.2.2 Dual-Port SRAM Modules

The A42MX36 device contains dual-port SRAM modules that have been optimized for synchronous or asynchronous applications. The SRAM modules are arranged in 256-bit blocks that can be configured as 32x8 or 64x4. SRAM modules can be cascaded together to form memory spaces of user-definable width and depth. A block diagram of the A42MX36 dual-port SRAM block is shown in Figure 6, page 9.

The A42MX36 SRAM modules are true dual-port structures containing independent read and write ports. Each SRAM module contains six bits of read and write addressing (RDAD[5:0] and WRAD[5:0], respectively) for 64x4-bit blocks. When configured in byte mode, the highest order address bits (RDAD5 and WRAD5) are not used. The read and write ports of the SRAM block contain independent clocks (RCLK and WCLK) with programmable polarities offering active HIGH or LOW implementation. The SRAM block contains eight data inputs (WD[7:0]), and eight outputs (RD[7:0]), which are connected to segmented vertical routing tracks.

The A42MX36 dual-port SRAM blocks provide an optimal solution for high-speed buffered applications requiring FIFO and LIFO queues. The ACTgen Macro Builder within Microsemi's designer software provides capability to quickly design memory functions with the SRAM blocks. Unused SRAM blocks can be used to implement registers for other user logic within the design.

- VCCA = Power supply in volts (V)
- F = Switching frequency in megahertz (MHz)

### 3.4.4 Equivalent Capacitance

Equivalent capacitance is calculated by measuring ICCactive at a specified frequency and voltage for each circuit component of interest. Measurements have been made over a range of frequencies at a fixed value of VCC. Equivalent capacitance is frequency-independent, so the results can be used over a wide range of operating conditions. Equivalent capacitance values are shown below.

### 3.4.5 C<sub>EQ</sub> Values for Microsemi MX FPGAs

Modules (C<sub>EQM</sub>)3.5

Input Buffers (C<sub>EQI</sub>)6.9

Output Buffers (C<sub>EQO</sub>)18.2

Routed Array Clock Buffer Loads (C<sub>EQCR</sub>)1.4

To calculate the active power dissipated from the complete design, the switching frequency of each part of the logic must be known. The equation below shows a piece-wise linear summation over all components.

$$\text{Power} = \text{VCCA}^2 * [(m * C_{EQM} * f_m)_{\text{modules}} + (n * C_{EQI} * f_n)_{\text{inputs}} + (p * (C_{EQO} + C_L) * f_p)_{\text{outputs}} + \\ 0.5 * (q_1 * C_{EQCR} * f_{q1})_{\text{routed\_Clk1}} + (r_1 * f_{q1})_{\text{routed\_Clk1}} + \\ 0.5 * (q_2 * C_{EQCR} * f_{q2})_{\text{routed\_Clk2}} + (r_2 * f_{q2})_{\text{routed\_Clk2}}(2)]$$

**EQ 3**

where:

m = Number of logic modules switching at frequency f<sub>m</sub>

n = Number of input buffers switching at frequency f<sub>n</sub>

p = Number of output buffers switching at frequency f<sub>p</sub>

q<sub>1</sub> = Number of clock loads on the first routed array clock

q<sub>2</sub> = Number of clock loads on the second routed array clock

r<sub>1</sub> = Fixed capacitance due to first routed array clock

r<sub>2</sub> = Fixed capacitance due to second routed array clock

C<sub>EQM</sub> = Equivalent capacitance of logic modules in pF

C<sub>EQI</sub> = Equivalent capacitance of input buffers in pF

C<sub>EQO</sub> = Equivalent capacitance of output buffers in pF

C<sub>EQCR</sub> = Equivalent capacitance of routed array clock in pF

C<sub>L</sub> = Output load capacitance in pF

f<sub>m</sub> = Average logic module switching rate in MHz

f<sub>n</sub> = Average input buffer switching rate in MHz

f<sub>p</sub> = Average output buffer switching rate in MHz

f<sub>q1</sub> = Average first routed array clock rate in MHz

**Note:** \*Stresses beyond those listed under “Absolute Maximum Ratings” may cause permanent damage to the device. Exposure to absolute maximum rated conditions for extended periods may affect device reliability. Devices should not be operated outside the recommended operating conditions.

**Table 14 • Recommended Operating Conditions**

Parameter	Commercial	Industrial	Military	Units
Temperature Range*	0 to +70	–40 to +85	–55 to +125	°C
VCC (40MX)	4.75 to 5.25	4.5 to 5.5	4.5 to 5.5	V
VCCA (42MX)	4.75 to 5.25	4.5 to 5.5	4.5 to 5.5	V
VCCI (42MX)	4.75 to 5.25	4.5 to 5.5	4.5 to 5.5	V

**Note:** \* Ambient temperature ( $T_A$ ) is used for commercial and industrial grades; case temperature ( $T_C$ ) is used for military grades.

### 3.7.1 5 V TTL Electrical Specifications

The following tables show 5 V TTL electrical specifications.

**Table 15 • 5V TTL Electrical Specifications**

Symbol	Parameter	Commercial		Commercial -F		Industrial		Military		Units
		Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	
VOH <sup>1</sup>	IOH = –10 mA	2.4		2.4						V
	IOH = –4 mA					3.7		3.7		V
VOL <sup>1</sup>	IOL = 10 mA	0.5		0.5						V
	IOL = 6 mA					0.4		0.4		V
VIL		–0.3	0.8	–0.3	0.8	–0.3	0.8	–0.3	0.8	V
VIH (40MX)		2.0	VCC + 0.3	2.0	VCC + 0.3	2.0	VCC + 0.3	2.0	VCC + 0.3	V
VIH (42MX) <sup>2</sup>		2.0	VCCI + 0.3	2.0	VCCI + 0.3	2.0	VCCI + 0.3	2.0	VCCI + 0.3	V
IIL	VIN = 0.5 V	–10		–10		–10		–10		μA
IIH	VIN = 2.7 V	–10		–10		–10		–10		μA
Input Transition Time, $T_R$ and $T_F$		500		500		500		500		ns
$C_{IO}$ I/O Capacitance		10		10		10		10		pF
Standby Current, $ICC^3$	A40MX02, A40MX04	3		25		10		25		mA
	A42MX09	5		25		25		25		mA
	A42MX16	6		25		25		25		mA
	A42MX24, A42MX36	20		25		25		25		mA
Low power mode Standby Current	42MX devices only	0.5		ICC – 5.0		ICC – 5.0		ICC – 5.0		mA
IIO, I/O source sink current	Can be derived from the <i>IBIS model</i> ( <a href="http://www.microsemi.com/soc/techdocs/models/ibis.html">http://www.microsemi.com/soc/techdocs/models/ibis.html</a> )									

1. Only one output tested at a time. VCC/VCCI = min

2. VIH(Min) is 2.4V for A42MX36 family. This applies only to VCCI of 5V and is not applicable to VCCI of 3.3V

**Table 39 • A42MX09 Timing Characteristics (Nominal 3.3 V Operation) (continued)(Worst-Case Commercial Conditions, VCCA = 3.0 V, TJ = 70°C)**

<b>Parameter / Description</b>	<b>-3 Speed</b>		<b>-2 Speed</b>		<b>-1 Speed</b>		<b>Std Speed</b>		<b>-F Speed</b>		<b>Units</b>
	<b>Min.</b>	<b>Max.</b>	<b>Min.</b>	<b>Max.</b>	<b>Min.</b>	<b>Max.</b>	<b>Min.</b>	<b>Max.</b>	<b>Min.</b>	<b>Max.</b>	
<b>TTL Output Module Timing<sup>5</sup></b>											
t <sub>DLH</sub>	Data-to-Pad HIGH		3.4		3.8		4.3		5.1		7.1 ns
t <sub>DHL</sub>	Data-to-Pad LOW		4.0		4.5		5.1		6.1		8.3 ns
t <sub>ENZH</sub>	Enable Pad Z to HIGH		3.7		4.1		4.6		5.5		7.6 ns
t <sub>ENZL</sub>	Enable Pad Z to LOW		4.1		4.5		5.1		6.1		8.5 ns
t <sub>ENHZ</sub>	Enable Pad HIGH to Z		6.9		7.6		8.6		10.2		14.2 ns
t <sub>ENLZ</sub>	Enable Pad LOW to Z		7.5		8.3		9.4		11.1		15.5 ns
t <sub>GLH</sub>	G-to-Pad HIGH		5.8		6.5		7.3		8.6		12.0 ns
t <sub>GHL</sub>	G-to-Pad LOW		5.8		6.5		7.3		8.6		12.0 ns
t <sub>LSU</sub>	I/O Latch Set-Up	0.7		0.8		0.9		1.0		1.4	ns
t <sub>LH</sub>	I/O Latch Hold	0.0		0.0		0.0		0.0		0.0	ns
t <sub>LCO</sub>	I/O Latch Clock-to-Out (Pad-to-Pad), 64 Clock Loading		8.7		9.7		10.9		12.9		18.0 ns
t <sub>ACO</sub>	Array Clock-to-Out (Pad-to-Pad), 64 Clock Loading		12.2		13.5		15.4		18.1		25.3 ns
d <sub>TLH</sub>	Capacity Loading, LOW to HIGH	0.00		0.00		0.00		0.10		0.01	ns/pF
d <sub>THL</sub>	Capacity Loading, HIGH to LOW	0.09		0.10		0.10		0.10		0.10	ns/pF

**Table 44 • A42MX36 Timing Characteristics (Nominal 5.0 V Operation)(Worst-Case Commercial Conditions, VCCA = 4.75 V, TJ = 70°C)**

Parameter / Description	-3 Speed		-2 Speed		-1 Speed		Std Speed		-F Speed		Units
	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	
<b>Logic Module Combinatorial Functions<sup>1</sup></b>											
t <sub>PD</sub>	Internal Array Module Delay	1.3	1.5	1.7	2.0	2.7	ns				
t <sub>PDD</sub>	Internal Decode Module Delay	1.6	1.8	2.0	2.4	3.3	ns				
<b>Logic Module Predicted Routing Delays<sup>2</sup></b>											
t <sub>RD1</sub>	FO = 1 Routing Delay	0.9	1.0	1.2	1.4	2.0	ns				
t <sub>RD2</sub>	FO = 2 Routing Delay	1.3	1.4	1.6	1.9	2.7	ns				
t <sub>RD3</sub>	FO = 3 Routing Delay	1.6	1.8	2.0	2.4	3.4	ns				
t <sub>RD4</sub>	FO = 4 Routing Delay	2.0	2.2	2.5	2.9	4.1	ns				
t <sub>RD5</sub>	FO = 8 Routing Delay	3.3	3.7	4.2	4.9	6.9	ns				
t <sub>RDD</sub>	Decode-to-Output Routing Delay	0.3	0.4	0.4	0.5	0.7	ns				
<b>Logic Module Sequential Timing<sup>3, 4</sup></b>											
t <sub>CO</sub>	Flip-Flop Clock-to-Output	1.3	1.4	1.6	1.9	2.7	ns				
t <sub>GO</sub>	Latch Gate-to-Output	1.3	1.4	1.6	1.9	2.7	ns				
t <sub>SUD</sub>	Flip-Flop (Latch) Set-Up Time	0.3	0.3	0.4	0.5	0.7	ns				
t <sub>HD</sub>	Flip-Flop (Latch) Hold Time	0.0	0.0	0.0	0.0	0.0	ns				
t <sub>RO</sub>	Flip-Flop (Latch) Reset-to-Output	1.6	1.7	2.0	2.3	3.2	ns				
t <sub>SUENA</sub>	Flip-Flop (Latch) Enable Set-Up	0.7	0.8	0.9	1.0	1.4	ns				
t <sub>HENA</sub>	Flip-Flop (Latch) Enable Hold	0.0	0.0	0.0	0.0	0.0	ns				
t <sub>WCLKA</sub>	Flip-Flop (Latch) Clock Active Pulse Width	3.3	3.7	4.2	4.9	6.9	ns				
t <sub>WASYN</sub>	Flip-Flop (Latch) Asynchronous Pulse Width	4.4	4.8	5.5	6.4	9.0	ns				
<b>Synchronous SRAM Operations</b>											
t <sub>RC</sub>	Read Cycle Time	6.8	7.5	8.5	10.0	14.0	ns				
t <sub>WC</sub>	Write Cycle Time	6.8	7.5	8.5	10.0	14.0	ns				
t <sub>RCKHL</sub>	Clock HIGH/LOW Time	3.4	3.8	4.3	5.0	7.0	ns				
t <sub>RCO</sub>	Data Valid After Clock HIGH/LOW	3.4	3.8	4.3	5.0	7.0	ns				
t <sub>ADSU</sub>	Address/Data Set-Up Time	1.6	1.8	2.0	2.4	3.4	ns				
<b>Synchronous SRAM Operations (continued)</b>											
t <sub>ADH</sub>	Address/Data Hold Time	0.0	0.0	0.0	0.0	0.0	ns				
t <sub>RENSU</sub>	Read Enable Set-Up	0.6	0.7	0.8	0.9	1.3	ns				
t <sub>RENH</sub>	Read Enable Hold	3.4	3.8	4.3	5.0	7.0	ns				
t <sub>WENSU</sub>	Write Enable Set-Up	2.7	3.0	3.4	4.0	5.6	ns				
t <sub>WENH</sub>	Write Enable Hold	0.0	0.0	0.0	0.0	0.0	ns				
t <sub>BENS</sub>	Block Enable Set-Up	2.8	3.1	3.5	4.1	5.7	ns				
t <sub>BENH</sub>	Block Enable Hold	0.0	0.0	0.0	0.0	0.0	ns				

**Table 44 • A42MX36 Timing Characteristics (Nominal 5.0 V Operation)(Worst-Case Commercial Conditions, VCCA = 4.75 V, TJ = 70°C)**

Parameter / Description	-3 Speed		-2 Speed		-1 Speed		Std Speed		-F Speed		Units
	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	
<b>CMOS Output Module Timing<sup>5</sup></b>											
t <sub>DLH</sub>	Data-to-Pad HIGH		3.5		3.9		4.5		5.2		7.3 ns
t <sub>DHL</sub>	Data-to-Pad LOW		2.5		2.7		3.1		3.6		5.1 ns
t <sub>ENZH</sub>	Enable Pad Z to HIGH		2.7		3.0		3.3		3.9		5.5 ns
t <sub>ENZL</sub>	Enable Pad Z to LOW		2.9		3.3		3.7		4.3		6.1 ns
t <sub>ENHZ</sub>	Enable Pad HIGH to Z		5.3		5.8		6.6		7.8		10.9 ns
t <sub>ENLZ</sub>	Enable Pad LOW to Z		4.9		5.5		6.2		7.3		10.2 ns
t <sub>GLH</sub>	G-to-Pad HIGH		5.0		5.6		6.3		7.5		10.4 ns
t <sub>GHL</sub>	G-to-Pad LOW		5.0		5.6		6.3		7.5		10.4 ns
t <sub>LSU</sub>	I/O Latch Set-Up	0.5		0.5		0.6		0.7		1.0	ns
t <sub>LH</sub>	I/O Latch Hold	0.0		0.0		0.0		0.0		0.0	ns
t <sub>LCO</sub>	I/O Latch Clock-to-Out (Pad-to-Pad) 32 I/O		5.7		6.3		7.1		8.4		11.8 ns
t <sub>ACO</sub>	Array Latch Clock-to-Out (Pad-to-Pad) 32 I/O		7.8		8.6		9.8		11.5		16.1 ns
d <sub>TLH</sub>	Capacitive Loading, LOW to HIGH		0.07		0.08		0.09		0.10		0.14 ns/pF
d <sub>THL</sub>	Capacitive Loading, HIGH to LOW		0.07		0.08		0.09		0.10		0.14 ns/pF

1. For dual-module macros, use  $t_{PD1} + t_{RD1} + t_{PDn}$ ,  $t_{CO} + t_{RD1} + t_{PDn}$ , or  $t_{PD1} + t_{RD1} + t_{SUD}$ , whichever is appropriate.
2. Routing delays are for typical designs across worst-case operating conditions. These parameters should be used for estimating device performance. Post-route timing analysis or simulation is required to determine actual performance.
3. Data applies to macros based on the S-module. Timing parameters for sequential macros constructed from C-modules can be obtained from the Timer utility.
4. Set-up and hold timing parameters for the Input Buffer Latch are defined with respect to the PAD and the D input. External setup/hold timing parameters must account for delay from an external PAD signal to the G inputs. Delay from an external PAD signal to the G input subtracts (adds) to the internal setup (hold) time.
5. Delays based on 35 pF loading.

**Table 45 • A42MX36 Timing Characteristics (Nominal 3.3 V Operation) (Worst-Case Commercial Conditions, VCCA = 3.0 V, TJ = 70°C)**

Parameter / Description	-3 Speed		-2 Speed		-1 Speed		Std Speed		-F Speed		Units
	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	
<b>Logic Module Combinatorial Functions<sup>1</sup></b>											
t <sub>PD</sub>	Internal Array Module Delay	1.9		2.1		2.3		2.7		3.8	ns
t <sub>PDD</sub>	Internal Decode Module Delay	2.2		2.5		2.8		3.3		4.7	ns
<b>Logic Module Predicted Routing Delays<sup>2</sup></b>											
t <sub>RD1</sub>	FO = 1 Routing Delay	1.3		1.5		1.7		2.0		2.7	ns
t <sub>RD2</sub>	FO = 2 Routing Delay	1.8		2.0		2.3		2.7		3.7	ns
t <sub>RD3</sub>	FO = 3 Routing Delay	2.3		2.5		2.8		3.4		4.7	ns
t <sub>RD4</sub>	FO = 4 Routing Delay	2.8		3.1		3.5		4.1		5.7	ns

**Table 45 • A42MX36 Timing Characteristics (Nominal 3.3 V Operation) (continued)(Worst-Case Commercial Conditions, VCCA = 3.0 V, TJ = 70°C)**

<b>Parameter / Description</b>	<b>-3 Speed</b>		<b>-2 Speed</b>		<b>-1 Speed</b>		<b>Std Speed</b>		<b>-F Speed</b>		<b>Units</b>
	<b>Min.</b>	<b>Max.</b>	<b>Min.</b>	<b>Max.</b>	<b>Min.</b>	<b>Max.</b>	<b>Min.</b>	<b>Max.</b>	<b>Min.</b>	<b>Max.</b>	
t <sub>ACO</sub>	Array Latch Clock-to-Out (Pad-to-Pad) 32 I/O		10.9		12.1		13.7		16.1		22.5 ns
d <sub>TLH</sub>	Capacitive Loading, LOW to HIGH		0.10		0.11		0.12		0.14		0.20 ns/pF
d <sub>THL</sub>	Capacitive Loading, HIGH to LOW		0.10		0.11		0.12		0.14		0.20 ns/pF
<b>CMOS Output Module Timing<sup>5</sup></b>											
t <sub>DLH</sub>	Data-to-Pad HIGH		4.9		5.5		6.2		7.3		10.3 ns
t <sub>DHL</sub>	Data-to-Pad LOW		3.4		3.8		4.3		5.1		7.1 ns
t <sub>ENZH</sub>	Enable Pad Z to HIGH		3.7		4.1		4.7		5.5		7.7 ns
t <sub>ENZL</sub>	Enable Pad Z to LOW		4.1		4.6		5.2		6.1		8.5 ns
t <sub>ENHZ</sub>	Enable Pad HIGH to Z		7.4		8.2		9.3		10.9		15.3 ns
t <sub>ENLZ</sub>	Enable Pad LOW to Z		6.9		7.6		8.7		10.2		14.3 ns
t <sub>GLH</sub>	G-to-Pad HIGH		7.0		7.8		8.9		10.4		14.6 ns
t <sub>GHL</sub>	G-to-Pad LOW		7.0		7.8		8.9		10.4		14.6 ns
t <sub>LSU</sub>	I/O Latch Set-Up		0.7		0.7		0.8		1.0		1.4 ns
t <sub>LH</sub>	I/O Latch Hold		0.0		0.0		0.0		0.0		ns
t <sub>LCO</sub>	I/O Latch Clock-to-Out (Pad-to-Pad) 32 I/O		7.9		8.8		10.0		11.8		16.5 ns

- For dual-module macros, use t<sub>PD1</sub> + t<sub>RD1</sub> + t<sub>PDn</sub>, t<sub>CO</sub> + t<sub>RD1</sub> + t<sub>PDn</sub>, or t<sub>PD1</sub> + t<sub>RD1</sub> + t<sub>SUD</sub>, whichever is appropriate.
- Routing delays are for typical designs across worst-case operating conditions. These parameters should be used for estimating device performance. Post-route timing analysis or simulation is required to determine actual performance.
- Data applies to macros based on the S-module. Timing parameters for sequential macros constructed from C-modules can be obtained from the Timer utility.
- Set-up and hold timing parameters for the Input Buffer Latch are defined with respect to the PAD and the D input. External setup/hold timing parameters must account for delay from an external PAD signal to the G inputs. Delay from an external PAD signal to the G input subtracts (adds) to the internal setup (hold) time.*
- Delays based on 35 pF loading.

## 3.12 Pin Descriptions

This section lists the pin descriptions for 40MX and 42MX series FPGAs.

### CLK/A/B, I/O Global Clock

Clock inputs for clock distribution networks. CLK is for 40MX while CLKA and CLKB are for 42MX devices. The clock input is buffered prior to clocking the logic modules. This pin can also be used as an I/O.

### DCLK, I/O Diagnostic Clock

Clock input for diagnostic probe and device programming. DCLK is active when the MODE pin is HIGH. This pin functions as an I/O when the MODE pin is LOW.

### GND, Ground

Input LOW supply voltage.

### I/O, Input/Output

**Table 50 • PQ 100**

<b>PQ100</b>	<b>Pin Number</b>	<b>A40MX02 Function</b>	<b>A40MX04 Function</b>	<b>A42MX09 Function</b>	<b>A42MX16 Function</b>
19	VCC	V <sub>CC</sub>		I/O	I/O
20	I/O	I/O		I/O	I/O
21	I/O	I/O		I/O	I/O
22	I/O	I/O	GND		GND
23	I/O	I/O		I/O	I/O
24	I/O	I/O		I/O	I/O
25	I/O	I/O		I/O	I/O
26	I/O	I/O		I/O	I/O
27	NC	NC		I/O	I/O
28	NC	NC		I/O	I/O
29	NC	NC		I/O	I/O
30	NC	NC		I/O	I/O
31	NC	I/O		I/O	I/O
32	NC	I/O		I/O	I/O
33	NC	I/O		I/O	I/O
34	I/O	I/O	GND		GND
35	I/O	I/O		I/O	I/O
36	GND	GND		I/O	I/O
37	GND	GND		I/O	I/O
38	I/O	I/O		I/O	I/O
39	I/O	I/O		I/O	I/O
40	I/O	I/O	VCCA		VCCA
41	I/O	I/O		I/O	I/O
42	I/O	I/O		I/O	I/O
43	VCC	VCC		I/O	I/O
44	VCC	VCC		I/O	I/O
45	I/O	I/O		I/O	I/O
46	I/O	I/O	GND		GND
47	I/O	I/O		I/O	I/O
48	NC	I/O		I/O	I/O
49	NC	I/O		I/O	I/O
50	NC	I/O		I/O	I/O
51	NC	NC		I/O	I/O
52	NC	NC	SDO, I/O		SDO, I/O
53	NC	NC		I/O	I/O
54	NC	NC		I/O	I/O
55	NC	NC		I/O	I/O

**Table 50 • PQ 100**

<b>PQ100</b>	<b>Pin Number</b>	<b>A40MX02 Function</b>	<b>A40MX04 Function</b>	<b>A42MX09 Function</b>	<b>A42MX16 Function</b>
56	VCC	VCC	I/O	I/O	
57	I/O	I/O	GND	GND	
58	I/O	I/O	I/O	I/O	
59	I/O	I/O	I/O	I/O	
60	I/O	I/O	I/O	I/O	
61	I/O	I/O	I/O	I/O	
62	I/O	I/O	I/O	I/O	
63	GND	GND	I/O	I/O	
64	I/O	I/O	LP	LP	
65	I/O	I/O	VCCA	VCCA	
66	I/O	I/O	VCCI	VCCI	
67	I/O	I/O	VCCA	VCCA	
68	I/O	I/O	I/O	I/O	
69	VCC	VCC	I/O	I/O	
70	I/O	I/O	I/O	I/O	
71	I/O	I/O	I/O	I/O	
72	I/O	I/O	GND	GND	
73	I/O	I/O	I/O	I/O	
74	I/O	I/O	I/O	I/O	
75	I/O	I/O	I/O	I/O	
76	I/O	I/O	I/O	I/O	
77	NC	NC	I/O	I/O	
78	NC	NC	I/O	I/O	
79	NC	NC	SDI, I/O	SDI, I/O	
80	NC	I/O	I/O	I/O	
81	NC	I/O	I/O	I/O	
82	NC	I/O	I/O	I/O	
83	I/O	I/O	I/O	I/O	
84	I/O	I/O	GND	GND	
85	I/O	I/O	I/O	I/O	
86	GND	GND	I/O	I/O	
87	GND	GND	PRA, I/O	PRA, I/O	
88	I/O	I/O	I/O	I/O	
89	I/O	I/O	CLKA, I/O	CLKA, I/O	
90	CLK, I/O	CLK, I/O	VCCA	VCCA	
91	I/O	I/O	I/O	I/O	
92	MODE	MODE	CLKB, I/O	CLKB, I/O	

**Table 51 • PQ144**

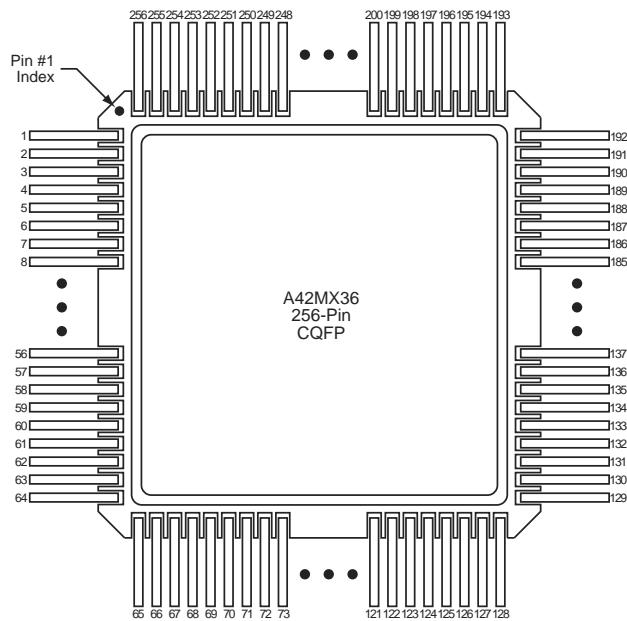
<b>PQ144</b>	
<b>Pin Number</b>	<b>A42MX09 Function</b>
6	I/O
7	I/O
8	I/O
9	GNDQ
10	GNDI
11	NC
12	I/O
13	I/O
14	I/O
15	I/O
16	I/O
17	I/O
18	VSV
19	VCC
20	VCCI
21	NC
22	I/O
23	I/O
24	I/O
25	I/O
26	I/O
27	I/O
28	GND
29	GNDI
30	NC
31	I/O
32	I/O
33	I/O
34	I/O
35	I/O
36	I/O
37	BININ
38	BINOUT
39	I/O
40	I/O
41	I/O
42	I/O

**Table 55 • VQ80**

<b>VQ80</b>		
<b>Pin Number</b>	<b>A40MX02 Function</b>	<b>A40MX04 Function</b>
49	I/O	I/O
50	CLK, I/O	CLK, I/O
51	I/O	I/O
52	MODE	MODE
53	VCC	VCC
54	NC	I/O
55	NC	I/O
56	NC	I/O
57	SDI, I/O	SDI, I/O
58	DCLK, I/O	DCLK, I/O
59	PRA, I/O	PRA, I/O
60	NC	NC
61	PRB, I/O	PRB, I/O
62	I/O	I/O
63	I/O	I/O
64	I/O	I/O
65	I/O	I/O
66	I/O	I/O
67	I/O	I/O
68	GND	GND
69	I/O	I/O
70	I/O	I/O
71	I/O	I/O
72	I/O	I/O
73	I/O	I/O
74	VCC	<b>VCC</b>
75	I/O	I/O
76	I/O	I/O
77	I/O	I/O
78	I/O	I/O
79	I/O	I/O
80	I/O	I/O

**Table 57 • TQ176**

<b>TQ176</b>	<b>Pin Number</b>	<b>A42MX09 Function</b>	<b>A42MX16 Function</b>	<b>A42MX24 Function</b>
	121	NC	NC	I/O
	122	I/O	I/O	I/O
	123	I/O	I/O	I/O
	124	NC	I/O	I/O
	125	NC	I/O	I/O
	126	NC	NC	I/O
	127	I/O	I/O	I/O
	128	I/O	I/O	I/O
	129	I/O	I/O	I/O
	130	I/O	I/O	I/O
	131	I/O	I/O	I/O
	132	I/O	I/O	I/O
	133	GND	GND	GND
	134	I/O	I/O	I/O
	135	SDI, I/O	SDI, I/O	SDI, I/O
	136	NC	I/O	I/O
	137	I/O	I/O	WD, I/O
	138	I/O	I/O	WD, I/O
	139	I/O	I/O	I/O
	140	NC	VCCI	VCCI
	141	I/O	I/O	I/O
	142	I/O	I/O	I/O
	143	NC	I/O	I/O
	144	NC	I/O	WD, I/O
	145	NC	NC	WD, I/O
	146	I/O	I/O	I/O
	147	NC	I/O	I/O
	148	I/O	I/O	I/O
	149	I/O	I/O	I/O
	150	I/O	I/O	WD, I/O
	151	NC	I/O	WD, I/O
	152	PRA, I/O	PRA, I/O	PRA, I/O
	153	I/O	I/O	I/O
	154	CLKA, I/O	CLKA, I/O	CLKA, I/O
	155	VCCA	VCCA	VCCA
	156	GND	GND	GND
	157	I/O	I/O	I/O

**Figure 50 • CQ256****Table 59 • CQ256**

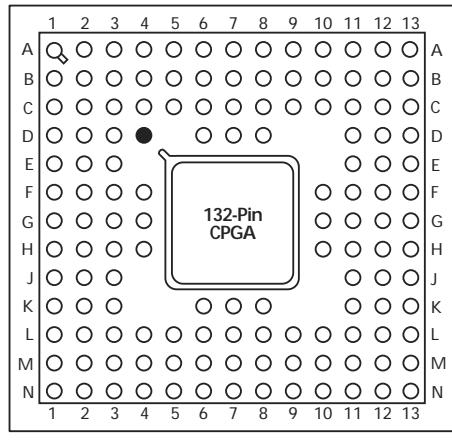
CQ256	
Pin Number	A42MX36 Function
1	NC
2	GND
3	I/O
4	I/O
5	I/O
6	I/O
7	I/O
8	I/O
9	I/O
10	GND
11	I/O
12	I/O
13	I/O
14	I/O
15	I/O
16	I/O
17	I/O
18	I/O
19	I/O
20	I/O
21	I/O

**Table 59 • CQ256**

<b>CQ256</b>	
<b>Pin Number</b>	<b>A42MX36 Function</b>
59	I/O
60	VCCA
61	GND
62	GND
63	NC
64	NC
65	NC
66	I/O
67	SDO, TDO, I/O
68	I/O
69	WD, I/O
70	WD, I/O
71	I/O
72	VCCI
73	I/O
74	I/O
75	I/O
76	WD, I/O
77	GND
78	WD, I/O
79	I/O
80	QCLKB, I/O
81	I/O
82	I/O
83	I/O
84	I/O
85	I/O
86	I/O
87	WD, I/O
88	WD, I/O
89	I/O
90	I/O
91	I/O
92	I/O
93	I/O
94	I/O
95	VCCI

**Table 60 • BG272**

<b>BG272</b>	
<b>Pin Number</b>	<b>A42MX36 Function</b>
Y13	I/O
Y14	I/O
Y15	I/O
Y16	I/O
Y17	I/O
Y18	WD, I/O
Y19	GND
Y20	GND

**Figure 52 • PG132**

● Orientation Pin

**Table 61 • PG132**

<b>PG132</b>	
<b>Pin Number</b>	<b>A42MX09 Function</b>
-	PMPOUT
B2	I/O
A1	MODE
B1	I/O
D3	I/O
C2	I/O
C1	I/O
D2	I/O
D1	I/O
E2	I/O
E1	I/O
F3	I/O

**Table 62 • CQ172**

21	I/O
22	GND
23	VCCI
24	VSV
25	I/O
26	I/O
27	VCC
28	I/O
29	I/O
30	I/O
31	I/O
32	GND
33	I/O
34	I/O
35	I/O
36	I/O
37	GND
38	I/O
39	I/O
40	I/O
41	I/O
42	I/O
43	I/O
44	BININ
45	BINOUT
46	I/O
47	I/O
48	I/O
49	I/O
50	VCCI
51	I/O
52	I/O
53	I/O
54	I/O
55	GND
56	I/O
57	I/O
58	I/O
59	I/O

**Table 62 • CQ172**

138	I/O
139	I/O
140	I/O
141	GND
142	I/O
143	I/O
144	I/O
145	I/O
146	I/O
147	I/O
148	PROBA
149	I/O
150	CLKA
151	VCC
152	GND
153	I/O
154	CLKB
155	I/O
156	PROBB
157	I/O
158	I/O
159	I/O
160	I/O
161	GND
162	I/O
163	I/O
164	I/O
165	I/O
166	VCCI
167	I/O
168	I/O
169	I/O
170	I/O
171	DCLK